Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/707,684	CHEN ET AL.
Examiner	Art Unit

2826

Tuan Quach

SEARCHED					
Class	Subclass	Date	Examiner		
257	685-687, 712, 713, 717, 777	1/17/2006	TQ		
257	778, 787	1/17/2005	TQ		
(update	search)				
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
interferen	search - see ce search tout	1/17/2006	TQ		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST (USPAT; USPGPUB; EPO; JPO; DERWENT, IBMTDB) see search history	1/17/2006	Τα		
EAST - USPGPUB text search - see interference search printout	1/17/2006	TQ		
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